## Notice of References Cited

Application/Control No. 10/764,660	Reexamination	Applicant(s)/Patent Under Reexamination HONG, SOON-HAC		
Examiner	Art Unit			
Eric A. Wiener	2179	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,829,009 B2	12-2004	Sugimoto, Masahiko	348/333.02
*	В	US-5,396,264 A	03-1995	Falcone et al.	715/811
*	С	US-6,310,648 B1	10-2001	Miller et al.	348/333.05
*	D	US-6,636,264 B1	10-2003	Nakao et al.	348/375
*	Ε	US-6,903,762 B2	06-2005	Prabhu et al.	348/207.1
	F	US-			
	G	US-			
	H	US-			
	Т	US-			
	J	US-			
	К	US-			
	Ľ	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002084447 A	03-2002	Japan	SUGIMOTO, MASAHIKO	·
	0		·		·	
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x ,	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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